Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/628,228	TAKENAKA, HIDEKI
Examiner	Art Unit
Alex Liew	2624

SEARCHED				
Class	Subclass	Date	Examiner	
			-	

Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
382/118 (limited to text search)	10/5/2006	AL
382/118 limited to text search	2/7/2007	AL
382/115,116,118 limited to text search	7/19/2007	AL